

501.42867X00

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s):

I. OCHIAI, et al

Serial No.:

10/601,531

Filed:

June 24, 2003

For:

ELECTRON MICROSCOPE INCLUDING APPARATUS FOR X-

RAY ANALYSIS AND METHOD OF ANALYZING SPECIMENS

**USING SAME** 

Group:

2881

Examiner:

D. Vanore

## <u>AMENDMENT</u>

Mail Stop Non-Fee Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

February 11, 2004

Sir:

In response to the Office Action November 12, 2003, the following amendments and remarks are respectfully submitted in connection with the above-identified application, as listed below and as set forth on the following pages:

Amendment of the Claims; and

Remarks are included following the amendments.